

Search Notes**Application/Control No.**

10/577,702

Examiner

Rip A. Lee

Applicant(s)/Patent under Reexamination

YANAGAWA ET AL.

Art Unit

1796

SEARCHED

Class	Subclass	Date	Examiner
526	169,2	01-18-2008	M
526	151	01-18-2008	M
526	352	01-18-2008	M
502	154	01-18-2008	M
502	157	01-18-2008	M
502	169	01-18-2008	M
502	152	01-18-2008	M
502	153	01-18-2008	M
502	117	01-18-2008	M

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	01-18-2008	M

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner